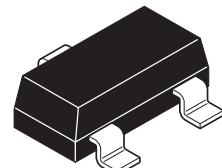


**ZXMN2A01F****20V N-CHANNEL ENHANCEMENT MODE MOSFET****SUMMARY**

$V_{(BR)DSS} = 20V$; $R_{DS(ON)} = 0.12\Omega$; $I_D = 2.2A$

DESCRIPTION

This new generation of trench MOSFETs from TY utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.

**SOT23****FEATURES**

- Low on-resistance
- Fast switching speed
- Low threshold
- Low gate drive
- SOT23 package

APPLICATIONS

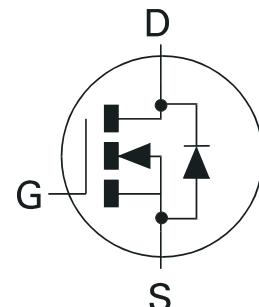
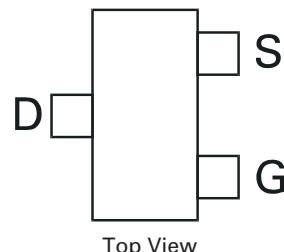
- DC - DC converters
- Power management functions
- Disconnect switches
- Motor control

ORDERING INFORMATION

DEVICE	REEL SIZE	TAPE WIDTH	QUANTITY PER REEL
ZXMN2A01FTA	7"	8mm	3000 units
ZXMN2A01FTC	13"	8mm	10000 units

DEVICE MARKING

- 7N2

**PINOUT**



ZXMN2A01F

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V_{DSS}	20	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current $V_{GS}=10V$; $T_A=25^\circ C$ (b) $V_{GS}=10V$; $T_A=70^\circ C$ (b) $V_{GS}=10V$; $T_A=25^\circ C$ (a)	I_D	2.2 1.7 1.9	A
Pulsed Drain Current (c)	I_{DM}	8	A
Continuous Source Current (Body Diode) (b)	I_S	1.29	A
Pulsed Source Current (Body Diode) (c)	I_{SM}	8	A
Power Dissipation at $T_A=25^\circ C$ (a) Linear Derating Factor	P_D	625 5	mW mW/ $^\circ C$
Power Dissipation at $T_A=25^\circ C$ (b) Linear Derating Factor	P_D	806 6.4	mW mW/ $^\circ C$
Operating and Storage Temperature Range	$T_J; T_{stg}$	-55 to +150	$^\circ C$

THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)	$R_{\theta JA}$	200	$^\circ C/W$
Junction to Ambient (b)	$R_{\theta JA}$	155	$^\circ C/W$

NOTES:

(a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions

(b) For a device surface mounted on FR4 PCB measured at $t \leq 5$ secs.

(c) Repetitive rating 25mm x 25mm FR4 PCB, $D = 0.02$, pulse width $300\mu s$ - pulse width limited by maximum junction temperature.



ZXMN2A01F

ELECTRICAL CHARACTERISTICS (at $T_A = 25^\circ\text{C}$ unless otherwise stated)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS.
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	20			V	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}			1	μA	$V_{DS}=20\text{V}, V_{GS}=0\text{V}$
Gate-Body Leakage	I_{GSS}			100	nA	$V_{GS}=\pm 12\text{V}, V_{DS}=0\text{V}$
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	0.7			V	$I_D=250\mu\text{A}, V_{DS}= V_{GS}$
Static Drain-Source On-State Resistance (1)	$R_{DS(\text{on})}$			0.12 0.225	Ω	$V_{GS}=4.5\text{V}, I_D=4\text{A}$ $V_{GS}=2.5\text{V}, I_D=1.5\text{A}$
Forward Transconductance (1)(3)	g_{fs}		6.1		S	$V_{DS}=10\text{V}, I_D=4\text{A}$
DYNAMIC (3)						
Input Capacitance	C_{iss}		303		pF	$V_{DS}=15\text{ V}, V_{GS}=0\text{V}, f=1\text{MHz}$
Output Capacitance	C_{oss}		59		pF	
Reverse Transfer Capacitance	C_{rss}		30		pF	
SWITCHING(2) (3)						
Turn-On Delay Time	$t_{d(on)}$		2.49		ns	$V_{DD}=10\text{V}, I_D=4\text{A}$ $R_G=6.0\Omega, V_{GS}=5\text{V}$
Rise Time	t_r		5.21		ns	
Turn-Off Delay Time	$t_{d(off)}$		7.47		ns	
Fall Time	t_f		4.62		ns	
Total Gate Charge	Q_g		3.0		nC	$V_{DS}=10\text{V}, V_{GS}=4.5\text{V}, I_D=4\text{A}$
Gate-Source Charge	Q_{gs}		0.8		nC	
Gate-Drain Charge	Q_{gd}		1.0		nC	
SOURCE-DRAIN DIODE						
Diode Forward Voltage (1)	V_{SD}		0.85	0.95	V	$T_J=25^\circ\text{C}, I_S=3.2\text{A}, V_{GS}=0\text{V}$
Reverse Recovery Time (3)	t_{rr}		23		ns	$T_J=25^\circ\text{C}, I_F= 4\text{A}, \frac{di}{dt}= 100\text{A}/\mu\text{s}$
Reverse Recovery Charge (3)	Q_{rr}		5.65		nC	

NOTES:

(1) Measured under pulsed conditions. Width=300μs. Duty cycle ≤2%.

(2) Switching characteristics are independent of operating junction temperature.

(3) For design aid only, not subject to production testing.